

Journal of Testing and Evaluation

Editorial Objectives

The **Journal of Testing and Evaluation** is published bimonthly by ASTM, a nonprofit technical organization that develops and publishes voluntary consensus standards and related information for materials, products, systems, and services. All contributions are peer reviewed prior to publication.

The editorial objectives of this journal are to serve a broad-based audience by:

1. Publishing new technical information derived from the field and laboratory testing, performance, quantitative characterization, and evaluation of these materials, products, systems, and services.
2. Presenting new methods and data and critical evaluations of these methods and data.
3. Reporting the users' experience with test methods and the results of interlaboratory testing and analysis.
4. Providing the scientific basis for both new and improved ASTM standards.
5. Stimulating new ideas in the fields of testing and evaluation.

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Journal of Testing and Evaluation (ISSN 0090-3973) is published bimonthly by ASTM as part of the Testing and Evaluation Series, which includes the *Geotechnical Testing Journal* (published quarterly), *Journal of Composites Technology & Research* (published quarterly), and *Cement, Concrete, and Aggregates* (published semi-annually). Publication and editorial offices are located at ASTM Headquarters, 1916 Race St., Philadelphia, PA 19103.

Subscriptions. *United States and Canada* for 1 year \$60.00 (members \$45.00), for 2 years \$105.00 (members \$78.00), and for 3 years \$135.00 (members \$104.00). *Foreign* for 1 year \$68.00 (members \$51.00), for 2 years \$120.00 (members \$90.00), and for 3 years \$158.00 (members \$122.00). Single copies are \$14.00. To subscribe, please send prepaid order to ASTM, Subscription Dept.—JTE, 1916 Race St., Philadelphia, PA 19103. *Journal of Testing and Evaluation* is indexed regularly by Engineering Index, Inc., and is available on microfilm from University Microfilms, a Xerox Co., Ann Arbor, MI. Second class postage paid at Philadelphia, PA. Copyright 1989 by the American Society for Testing and Materials.

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